

*flow*BOOST 0

600 V / 41 mΩ

**Features**

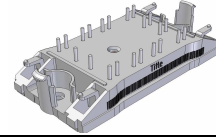
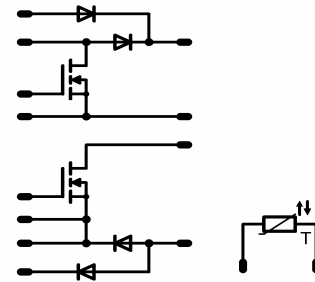
- High efficiency symmetric boost
- Ultrafast switching frequency with MOSFET
- Low inductance layout
- Tandem to NPC and MNPC modules

**Target Applications**

- Solar inverters
- UPS

**Types**

- 10-FZ06NBA041FS01-P915L78

**flow0 12 mm housing**

**Schematic**


## Maximum Ratings

 T<sub>j</sub>=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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**Bypass Diode**

Repetitive peak reverse voltage	V <sub>RRM</sub>		1600	V	
Forward current	I <sub>FAV</sub>	DC current	T <sub>h</sub> =80°C T <sub>c</sub> =80°C	42 57	A
Surge forward current	I <sub>FSM</sub>	t <sub>p</sub> =10ms	T <sub>j</sub> =25°C	370	A
I <sup>2</sup> t-value	I <sup>2</sup> t		T <sub>j</sub> =150°C	370	A <sup>2</sup> s
Power dissipation	P <sub>tot</sub>	T <sub>j</sub> =T <sub>jmax</sub>	T <sub>h</sub> =80°C T <sub>c</sub> =80°C	49 75	W
Maximum Junction Temperature	T <sub>jmax</sub>			150	°C

**Input Boost MOSFET**

Drain to source breakdown voltage	V <sub>DS</sub>			600	V
DC drain current	I <sub>D</sub>	T <sub>j</sub> =T <sub>jmax</sub>	T <sub>h</sub> =80°C T <sub>c</sub> =80°C	32 39	A
Pulsed drain current	I <sub>Dpulse</sub>	t <sub>p</sub> limited by T <sub>jmax</sub>		272	A
Power dissipation	P <sub>tot</sub>	T <sub>j</sub> =T <sub>jmax</sub>	T <sub>h</sub> =80°C T <sub>c</sub> =80°C	97 147	W
Gate-source peak voltage	V <sub>GS</sub>			±20	V
Maximum Junction Temperature	T <sub>jmax</sub>			150	°C

## Maximum Ratings

 $T_j=25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
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### Input Boost FWD

Peak Repetitive Reverse Voltage	$V_{RRM}$		600	V	
DC forward current	$I_F$	$T_j=T_{jmax}$	$T_h=80^{\circ}\text{C}$	29	A
			$T_c=80^{\circ}\text{C}$	38	
Repetitive peak forward current	$I_{FSM}$	$t_p$ limited by $T_{jmax}$	300	A	
Power dissipation	$P_{tot}$	$T_j=T_{jmax}$	$T_h=80^{\circ}\text{C}$	42	W
			$T_c=80^{\circ}\text{C}$	64	
Maximum Junction Temperature	$T_{jmax}$		150	$^{\circ}\text{C}$	

### Thermal Properties

Storage temperature	$T_{stg}$		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	$T_{op}$		-40...+( $T_{jmax} - 25$ )	$^{\circ}\text{C}$

### Insulation Properties

Insulation voltage	$V_{is}$	$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

**Characteristic Values**

Parameter	Symbol	Conditions					Value			Unit
		VGE [V] or VGS [V]	Vr [V] or VCE [V] or VDS [V]	IC [A] or IF [A] or ID [A]	T <sub>j</sub>	Min	Typ	Max		
<b>Bypass Diode</b>										
Forward voltage	V <sub>F</sub>				35	T <sub>j</sub> =25°C T <sub>j</sub> =125°C	0,8	0,99 0,91	1,3	V
Threshold voltage (for power loss calc. only)	V <sub>to</sub>				35	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,87 0,74		V
Slope resistance (for power loss calc. only)	r <sub>f</sub>				35	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,008 0,011		Ω
Reverse current	I <sub>r</sub>			1600		T <sub>j</sub> =25°C T <sub>j</sub> =125°C			0,1	mA
Thermal resistance chip to heatsink	R <sub>thJH</sub>	Thermal grease thickness≤50um λ = 1 W/mK						1,42		K/W

**Input Boost MOSFET**

Static drain to source ON resistance	R <sub>DS(on)</sub>		10		44,4	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,040 0,079		Ω
Gate threshold voltage	V <sub>(GS)th</sub>	VGS=VDS			0,00296	T <sub>j</sub> =25°C T <sub>j</sub> =125°C	2,4	3	3,6	V
Gate to Source Leakage Current	I <sub>gss</sub>		0	600		T <sub>j</sub> =25°C T <sub>j</sub> =125°C			100	nA
Zero Gate Voltage Drain Current	I <sub>dss</sub>		20	0		T <sub>j</sub> =25°C T <sub>j</sub> =125°C			5	μA
Turn On Delay Time	t <sub>d(ON)</sub>	Rgoff=8 Ω Rgon=8 Ω	10/0	400	15	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		35 33	ns	
Rise Time	t <sub>r</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		9 10		
Turn off delay time	t <sub>d(OFF)</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		275 300		
Fall time	t <sub>f</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		4 5		
Turn-on energy loss per pulse	E <sub>on</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,18 0,34		mWs
Turn-off energy loss per pulse	E <sub>off</sub>	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,07 0,08						
Total gate charge	Q <sub>g</sub>	Rgon=8 Ω	10	480	44	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		290	nC	
Gate to source charge	Q <sub>gs</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		36		
Gate to drain charge	Q <sub>gd</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		150		
Input capacitance	C <sub>iss</sub>	f=1MHz	0	100		T <sub>j</sub> =25°C		6530	pF	
Output capacitance	C <sub>oss</sub>									360
Reverse transfer capacitance	C <sub>rss</sub>									tbd.
Thermal resistance chip to heatsink	R <sub>thJH</sub>	Thermal grease thickness≤50um λ = 1 W/mK						0,72		K/W

**Input Boost FWD**

Forward voltage	V <sub>F</sub>				30	T <sub>j</sub> =25°C T <sub>j</sub> =125°C	1,7	2,11 1,59	2,7	V
Reverse leakage current	I <sub>rm</sub>		10/0	400		T <sub>j</sub> =25°C T <sub>j</sub> =125°C			100	μA
Peak recovery current	I <sub>RPM</sub>	Rgon=8 Ω	10/0	400	15	T <sub>j</sub> =25°C T <sub>j</sub> =125°C		18 30	μC	
Reverse recovery time	t <sub>rr</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		14 32		
Reverse recovery charge	Q <sub>rr</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,15 0,56		
Reverse recovered energy	E <sub>rec</sub>					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		0,02 0,07		mWs
Peak rate of fall of recovery current	di(rec)max/dt					T <sub>j</sub> =25°C T <sub>j</sub> =125°C		5321 1723		
Thermal resistance chip to heatsink	R <sub>thJH</sub>	Thermal grease thickness≤50um λ = 1 W/mK						1,67		K/W

**Thermistor**

Rated resistance	R <sub>25</sub>					T <sub>j</sub> =25°C	20,9	22	23,1	kΩ
	R <sub>100</sub>					T <sub>j</sub> =100°C		1486		Ω
Power dissipation	P					T <sub>j</sub> =25°C		200		mW
Power dissipation constant	B <sub>(25/100)</sub>					T <sub>j</sub> =25°C		2		K

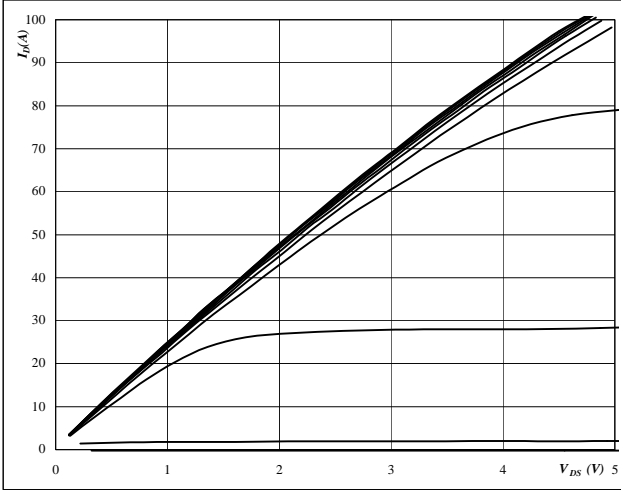
\* see details on Thermistor charts on Figure 2.

## INPUT BOOST

**Figure 1** BOOST MOSFET

**Typical output characteristics**

$$I_D = f(V_{DS})$$


**At**
 $t_p = 250 \mu s$   
 $T_j = 25 \text{ } ^\circ C$   
 $V_{DS}$  from 3 V to 13 V in steps of 1 V

**Figure 2** BOOST MOSFET

**Typical output characteristics**

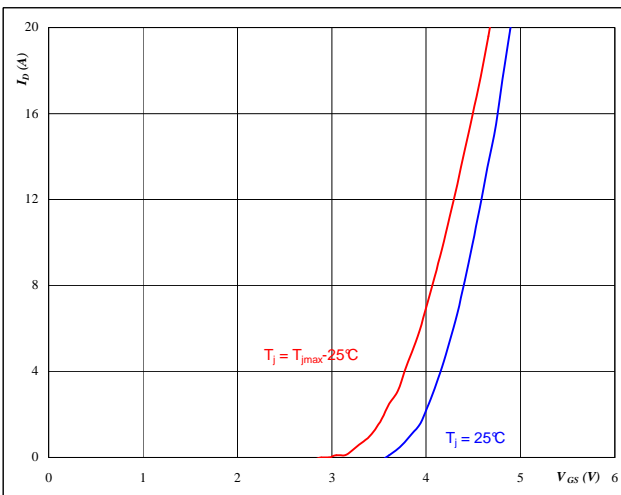
$$I_D = f(V_{DS})$$


**At**
 $t_p = 250 \mu s$   
 $T_j = 125 \text{ } ^\circ C$   
 $V_{DS}$  from 3 V to 13 V in steps of 1 V

**Figure 3** BOOST MOSFET

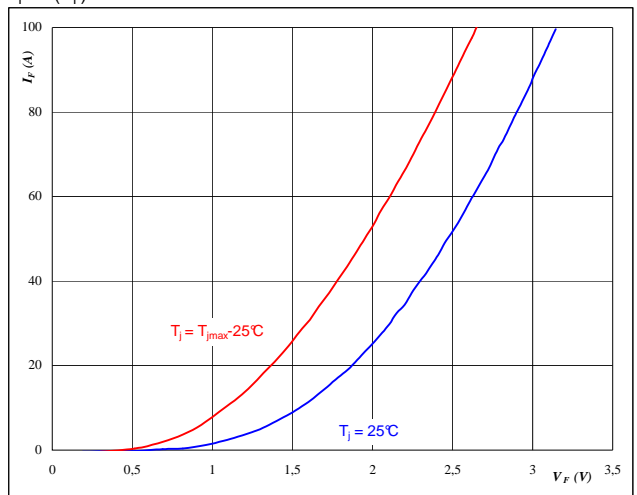
**Typical transfer characteristics**

$$I_D = f(V_{GS})$$


**At**
 $t_p = 250 \mu s$   
 $V_{DS} = 10 \text{ V}$ 
**Figure 4** BOOST FWD

**Typical diode forward current as a function of forward voltage**

$$I_F = f(V_F)$$

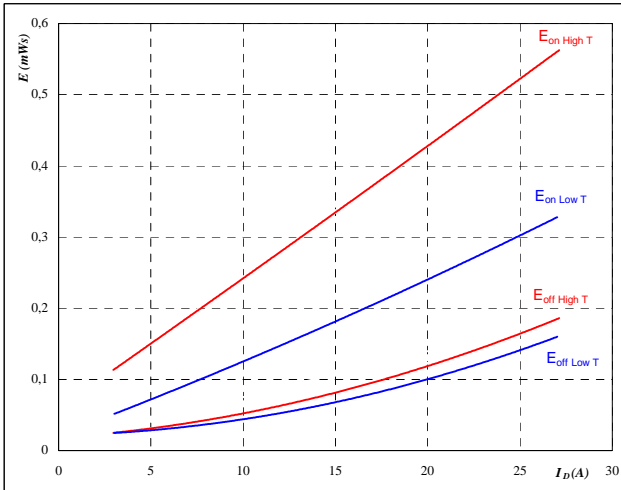

**At**
 $t_p = 250 \mu s$

## INPUT BOOST

**Figure 5** BOOST MOSFET

**Typical switching energy losses  
as a function of drain current**

$$E = f(I_D)$$



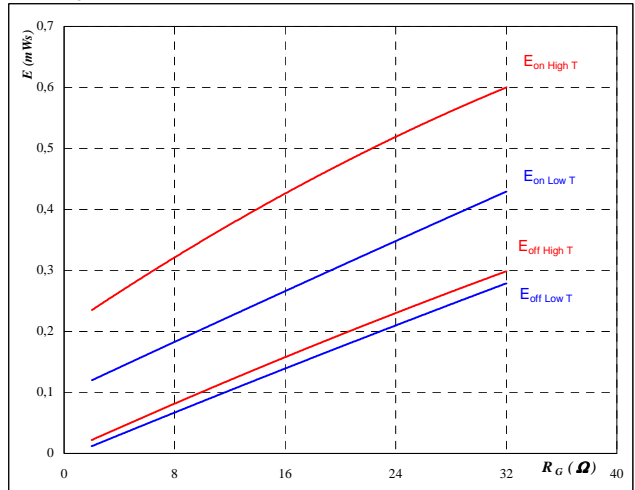
With an inductive load at

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω
$R_{goff} =$	8	Ω

**Figure 6** BOOST MOSFET

**Typical switching energy losses  
as a function of gate resistor**

$$E = f(R_G)$$



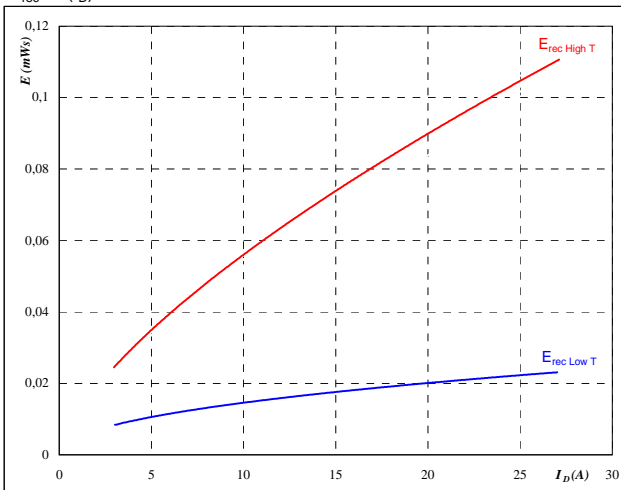
With an inductive load at

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$I_D =$	15	A

**Figure 7** BOOST MOSFET

**Typical reverse recovery energy loss  
as a function of drain current**

$$E_{rec} = f(I_D)$$



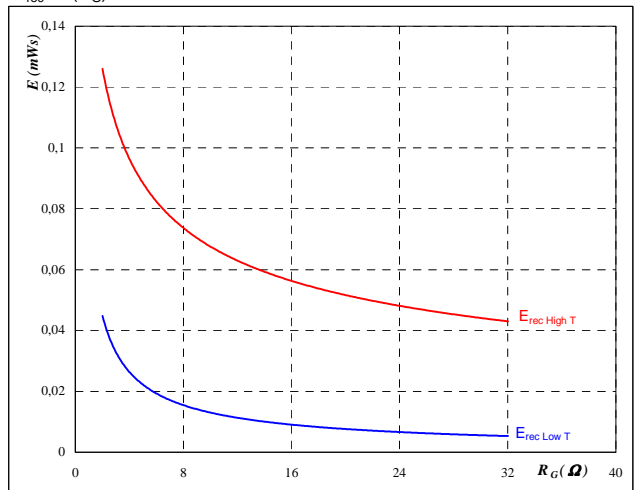
With an inductive load at

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω
$R_{goff} =$	8	Ω

**Figure 8** BOOST MOSFET

**Typical reverse recovery energy loss  
as a function of gate resistor**

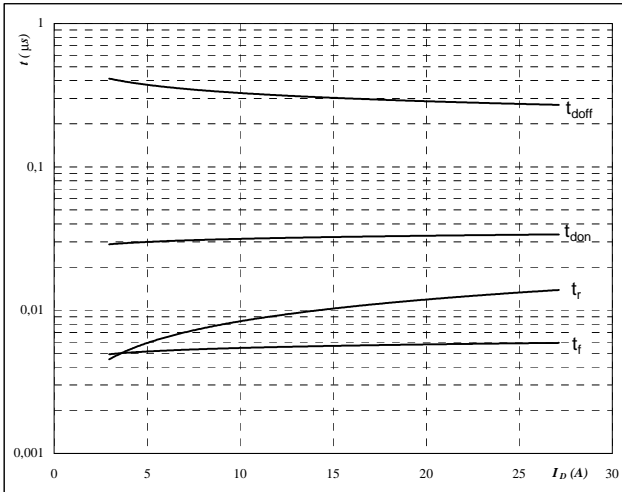
$$E_{rec} = f(R_G)$$



With an inductive load at

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$I_D =$	15	A

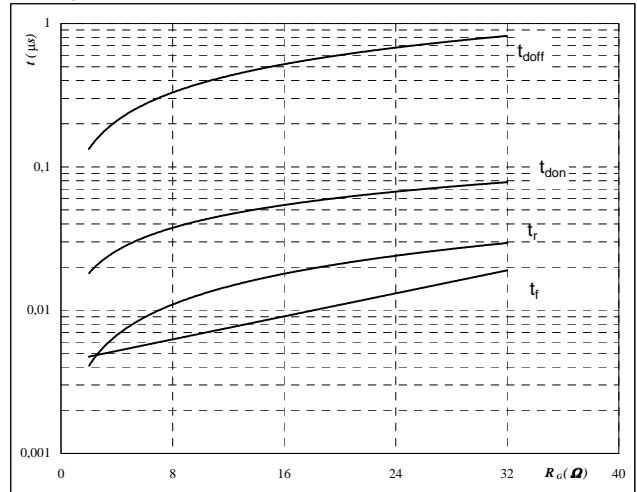
**INPUT BOOST**
**Figure 9** BOOST MOSFET

**Typical switching times as a function of drain current**  
 $t = f(I_D)$ 


With an inductive load at

$T_j =$	125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω
$R_{goff} =$	8	Ω

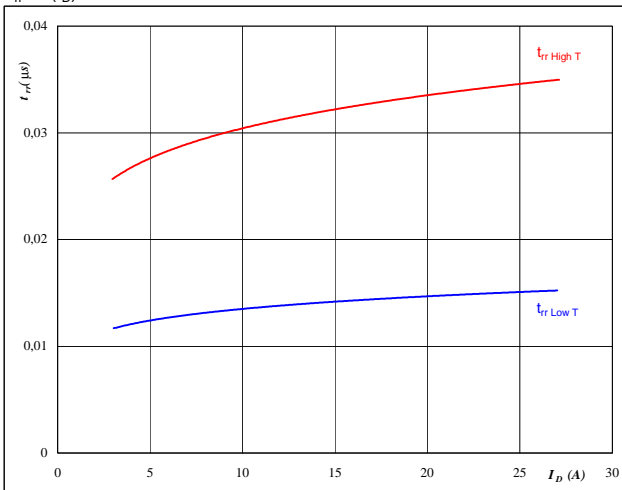
**Figure 10** BOOST MOSFET

**Typical switching times as a function of gate resistor**  
 $t = f(R_G)$ 


With an inductive load at

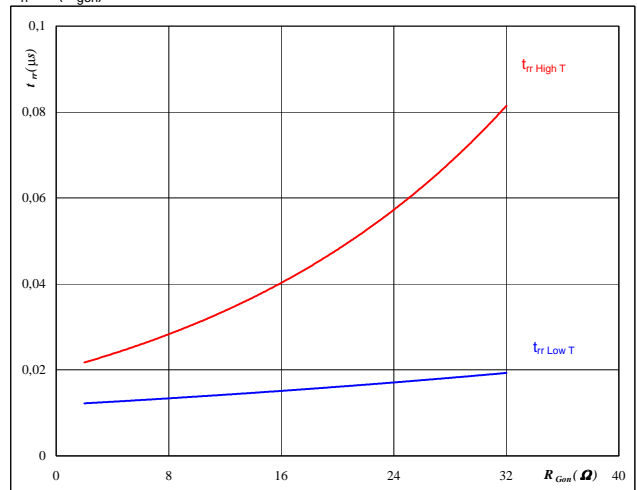
$T_j =$	125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$I_D =$	15	A

**Figure 11** BOOST FWD

**Typical reverse recovery time as a function of drain current**  
 $t_{rr} = f(I_D)$ 

**At**

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω

**Figure 12** BOOST FWD

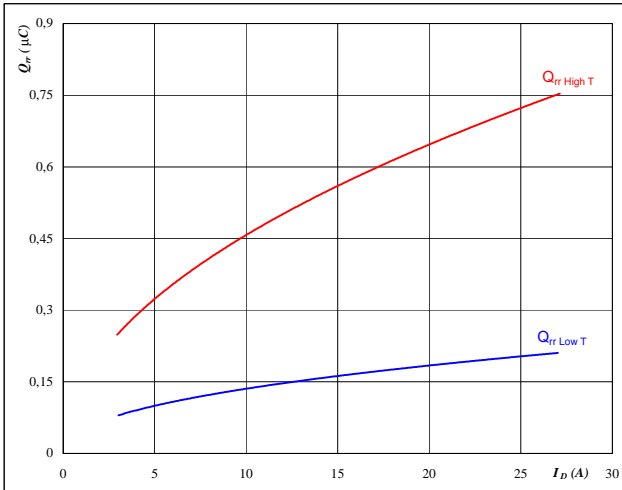
**Typical reverse recovery time as a function of MOSFET turn on gate resistor**  
 $t_{rr} = f(R_{gon})$ 

**At**

$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GS} =$	+10/0	V

**INPUT BOOST**
**Figure 13** BOOST FWD

**Typical reverse recovery charge as a function of drain current**

$$Q_{rr} = f(I_D)$$

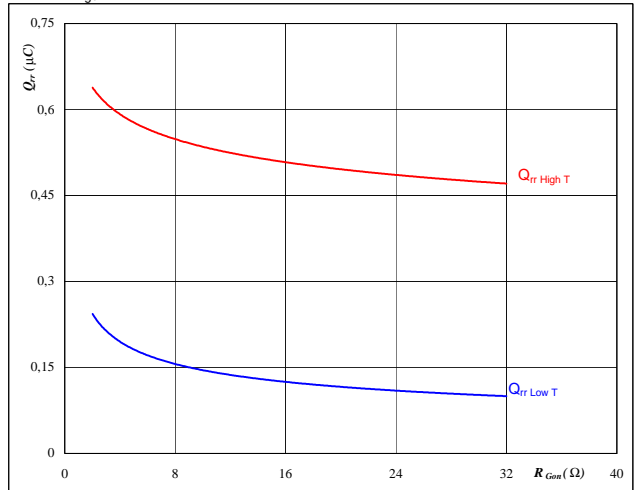

**At**

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω

**Figure 14** BOOST FWD

**Typical reverse recovery charge as a function of MOSFET turn on gate resistor**

$$Q_{rr} = f(R_{gon})$$

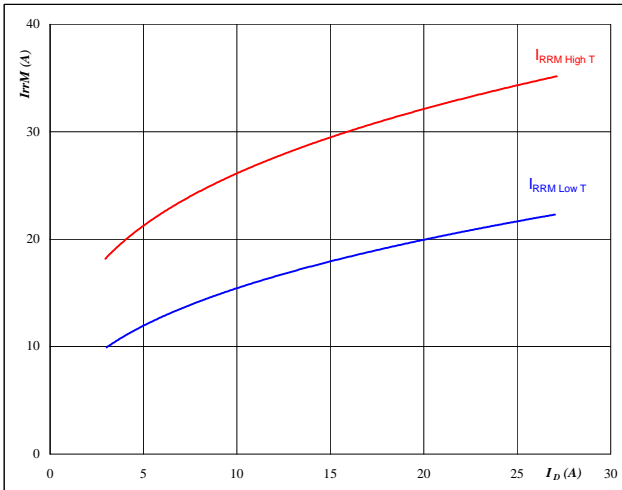

**At**

$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GS} =$	+10/0	V

**Figure 15** BOOST FWD

**Typical reverse recovery current as a function of drain current**

$$I_{RRM} = f(I_D)$$

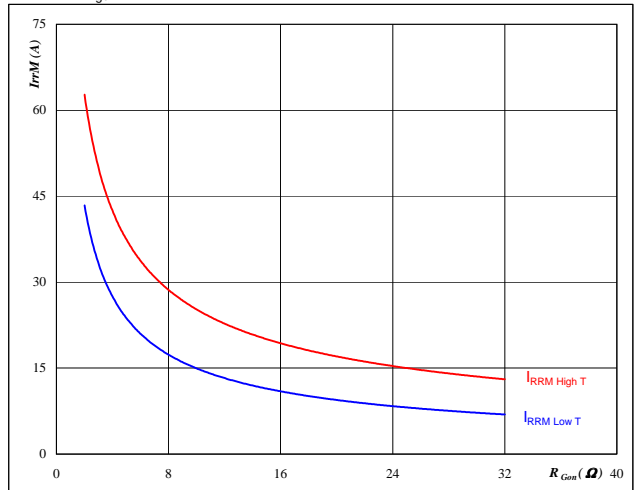

**At**

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω

**Figure 16** BOOST FWD

**Typical reverse recovery current as a function of MOSFET turn on gate resistor**

$$I_{RRM} = f(R_{gon})$$


**At**

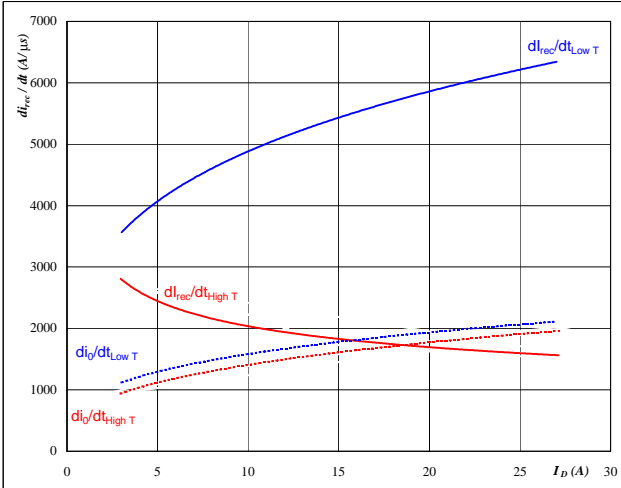
$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	15	A
$V_{GS} =$	+10/0	V

## INPUT BOOST

Figure 17 BOOST FWD

Typical rate of fall of forward and reverse recovery current as a function of drain current

$$dI_f/dt, dI_{rec}/dt = f(I_D)$$



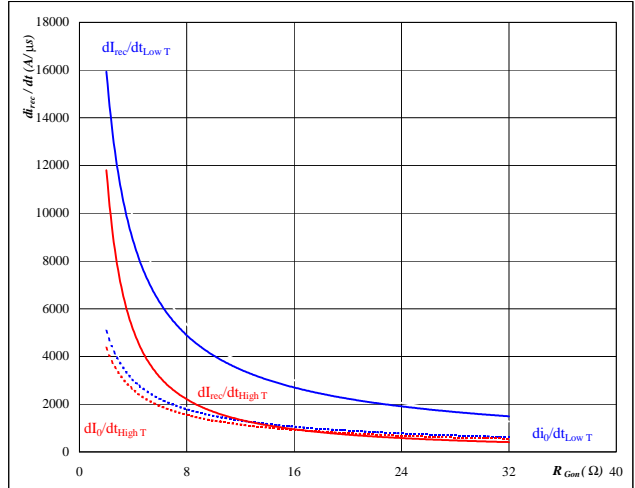
At

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$V_{GS} =$	+10/0	V
$R_{gon} =$	8	Ω

Figure 18 BOOST FWD

Typical rate of fall of forward and reverse recovery current as a function of MOSFET turn on gate resistor

$$dI_f/dt, dI_{rec}/dt = f(R_{gon})$$



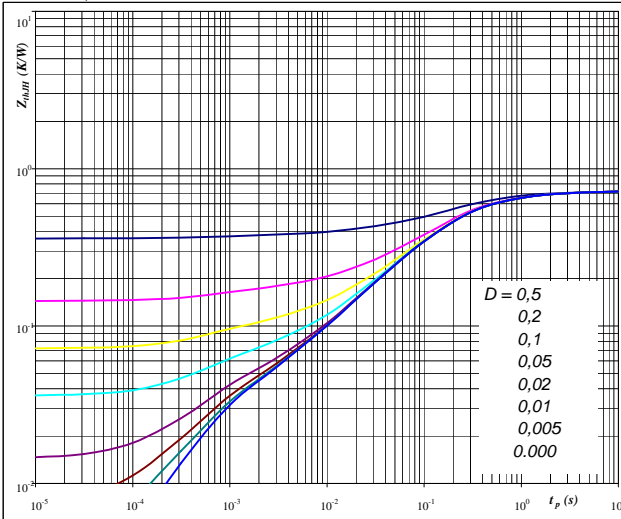
At

$T_j =$	25/125	°C
$V_{DS} =$	400	V
$I_f =$	15	A
$V_{GS} =$	+10/0	V

Figure 19 BOOST MOSFET

MOSFET transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At

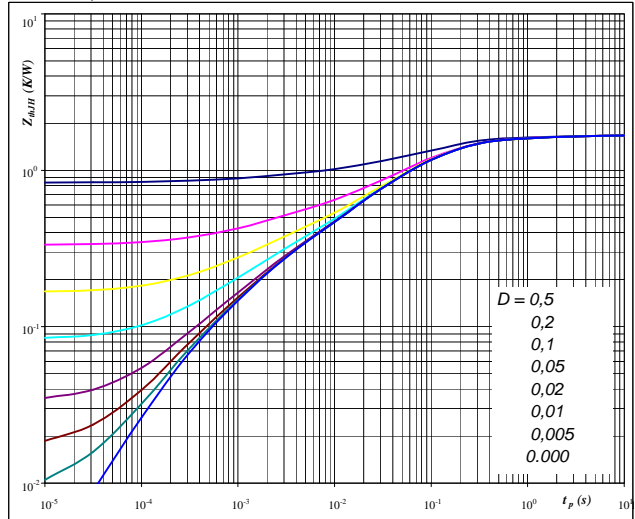
$D =$	$t_p / T$		
$R_{thJH} =$	0,72	K/W	MOSFET thermal model values

R (K/W)	Tau (s)
0,019	8,77E+00
0,106	1,31E+00
0,352	2,19E-01
0,164	6,50E-02
0,049	1,06E-02
0,031	7,41E-04

Figure 20 BOOST FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At

$D =$	$t_p / T$		
$R_{thJH} =$	1,67	K/W	FWD thermal model values

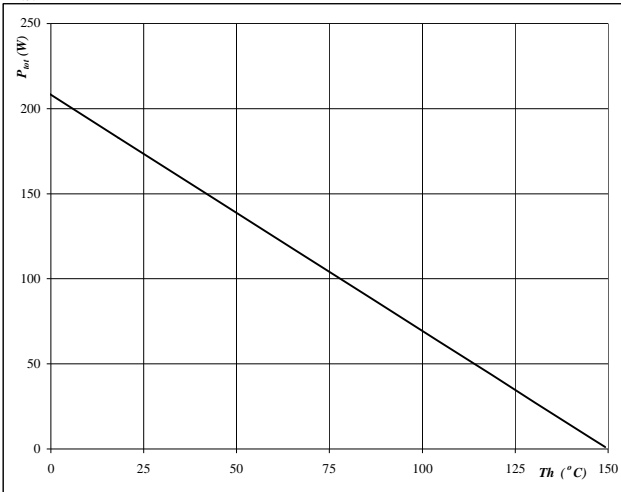
R (K/W)	Tau (s)
0,06	3,60E+00
0,24	4,21E-01
0,84	8,48E-02
0,32	1,50E-02
0,17	1,83E-03



**INPUT BOOST**
**Figure 21** BOOST MOSFET

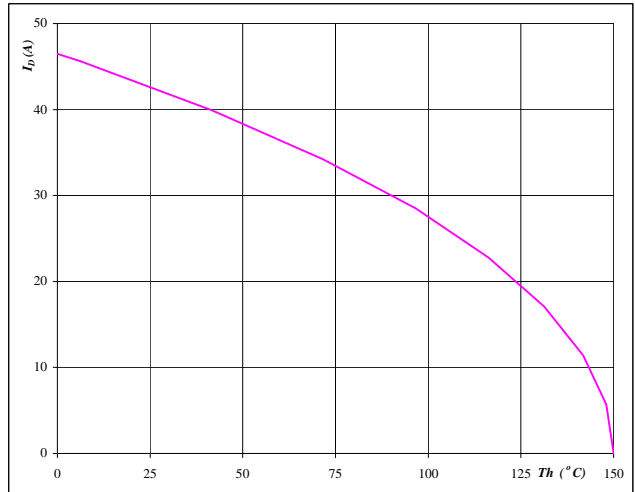
**Power dissipation as a function of heatsink temperature**

$$P_{tot} = f(T_h)$$


**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$ 
**Figure 22** BOOST MOSFET

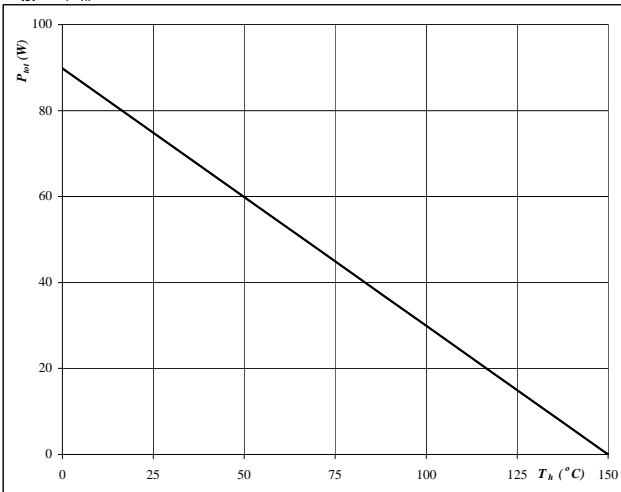
**Drain current as a function of heatsink temperature**

$$I_D = f(T_h)$$


**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$   
 $V_{GS} = 10 \text{ V}$ 
**Figure 23** BOOST FWD

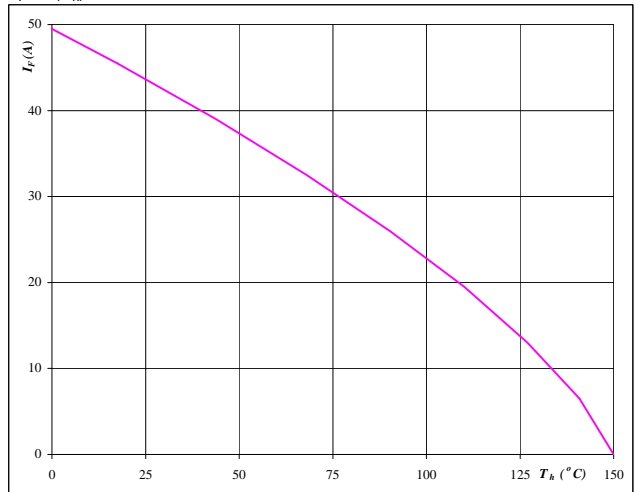
**Power dissipation as a function of heatsink temperature**

$$P_{tot} = f(T_h)$$


**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$ 
**Figure 24** BOOST FWD

**Forward current as a function of heatsink temperature**

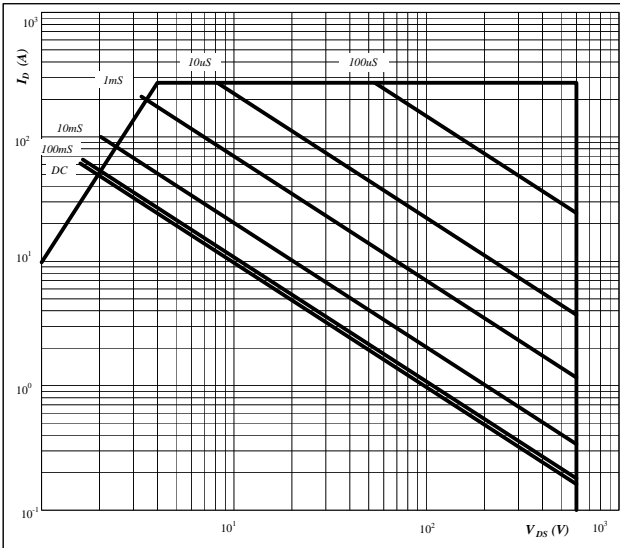
$$I_F = f(T_h)$$


**At**  
 $T_j = 150 \text{ } ^\circ\text{C}$

**INPUT BOOST**
**Figure 25** BOOST MOSFET

**Safe operating area as a function of drain-source voltage**

$$I_D = f(V_{DS})$$

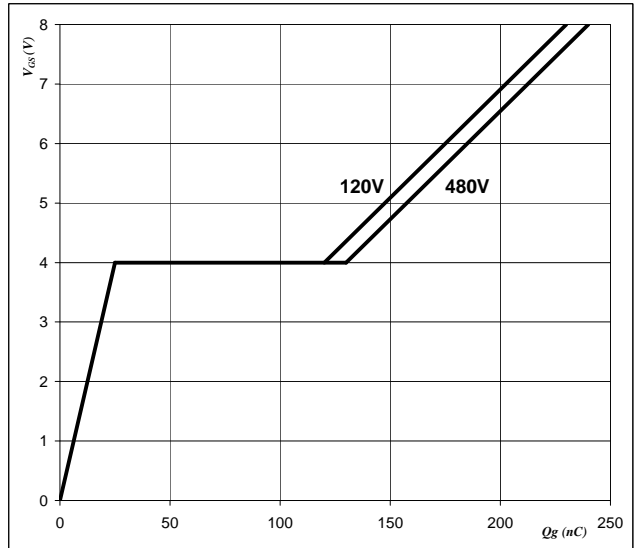


At  
 D = single pulse  
 $T_h = 80 \text{ } ^\circ\text{C}$   
 $V_{GS} = +10/0 \text{ V}$   
 $T_j = T_{jmax} \text{ } ^\circ\text{C}$

**Figure 26** BOOST MOSFET

**Gate voltage vs Gate charge**

$$V_{GS} = f(Q_g)$$



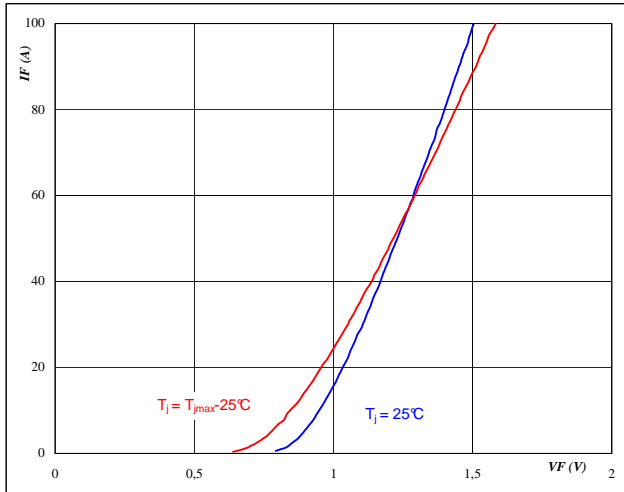
At  
 $I_D = 15 \text{ A}$

## Bypass Diode

**Figure 1** Bypass diode

**Typical diode forward current as a function of forward voltage**

$$I_F = f(V_F)$$

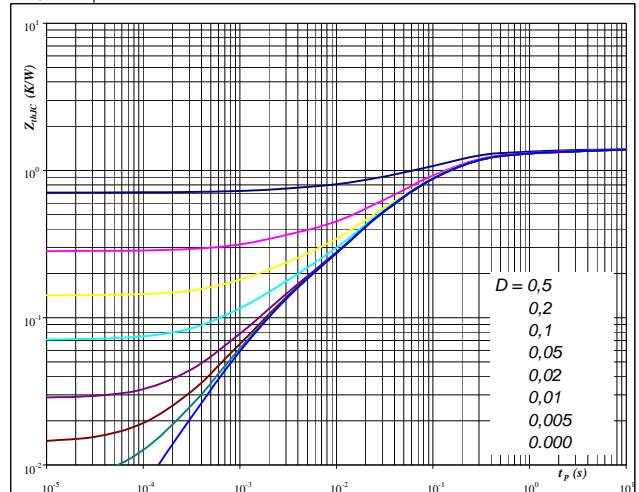

**At**

$$t_p = 250 \mu\text{s}$$

**Figure 2** Bypass diode

**Diode transient thermal impedance as a function of pulse width**

$$Z_{thJH} = f(t_p)$$


**At**

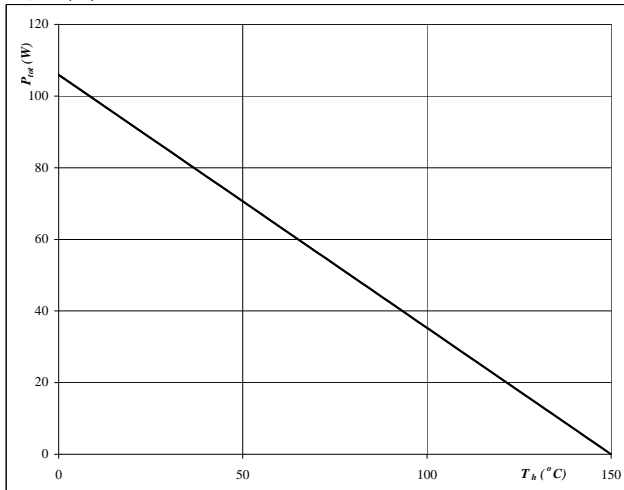
$$D = t_p / T$$

$$R_{thJH} = 1,42 \text{ K/W}$$

**Figure 3** Bypass diode

**Power dissipation as a function of heatsink temperature**

$$P_{tot} = f(T_h)$$

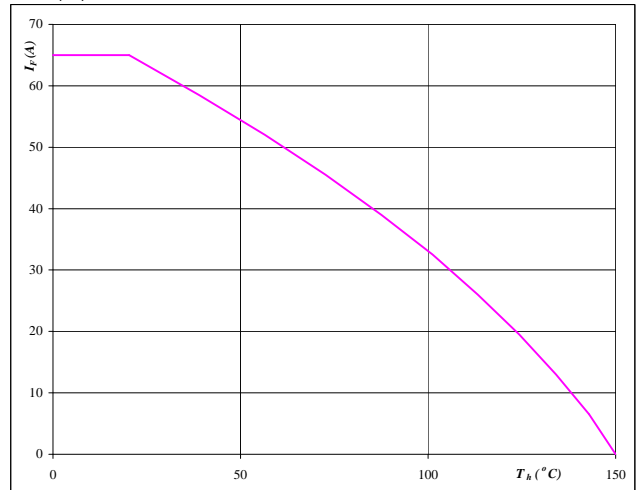

**At**

$$T_j = 150 \text{ } ^\circ\text{C}$$

**Figure 4** Bypass diode

**Forward current as a function of heatsink temperature**

$$I_F = f(T_h)$$

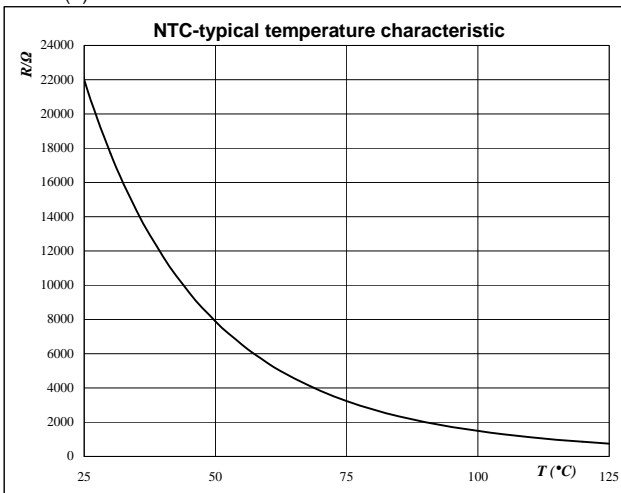

**At**

$$T_j = 150 \text{ } ^\circ\text{C}$$

## Thermistor

**Figure 1** Thermistor

Typical NTC characteristic  
 as a function of temperature

 $R_T = f(T)$ 

**Figure 2** Thermistor

Typical NTC resistance values

$$R(T) = R_{25} \cdot e^{\left( B_{25/100} \left( \frac{1}{T} - \frac{1}{T_{25}} \right) \right)} \quad [\Omega]$$

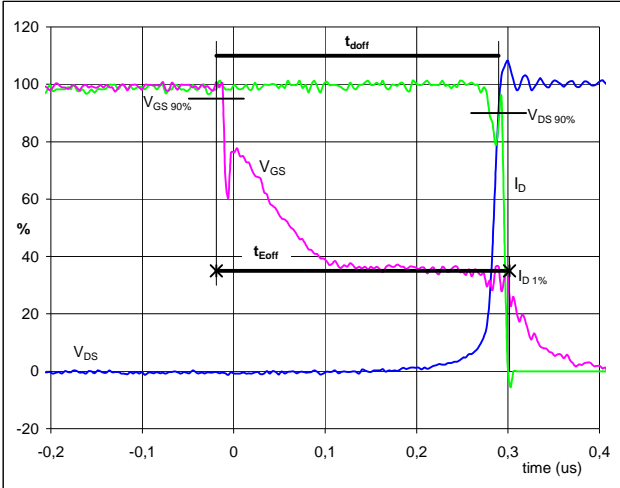
## Switching Definitions Boost MOSFET

**General conditions**

$T_j$	=	125 °C
$R_{gon}$	=	8 $\Omega$
$R_{goff}$	=	8 $\Omega$

**Figure 1** BOOST MOSFET

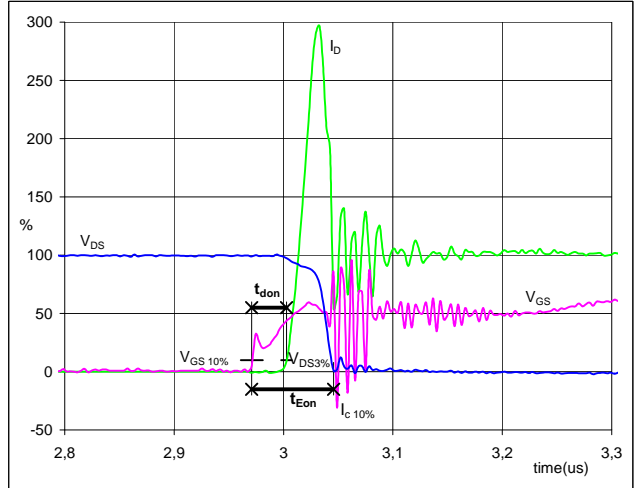
**Turn-off Switching Waveforms & definition of  $t_{doff}$ ,  $t_{Eoff}$** 

 ( $t_{Eoff}$  = integrating time for  $E_{off}$ )


$V_{GS}(0\%) =$	0	V
$V_{GS}(100\%) =$	10	V
$V_D(100\%) =$	400	V
$I_D(100\%) =$	15	A
$t_{doff} =$	0,30	$\mu$ S
$t_{Eoff} =$	0,32	$\mu$ S

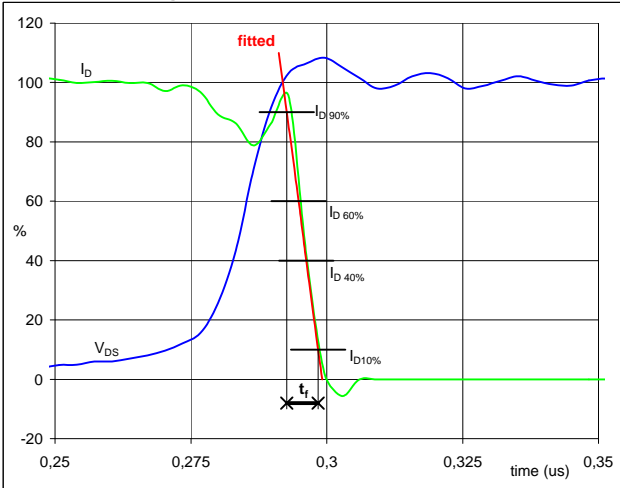
**Figure 2** BOOST MOSFET

**Turn-on Switching Waveforms & definition of  $t_{don}$ ,  $t_{Eon}$** 

 ( $t_{Eon}$  = integrating time for  $E_{on}$ )


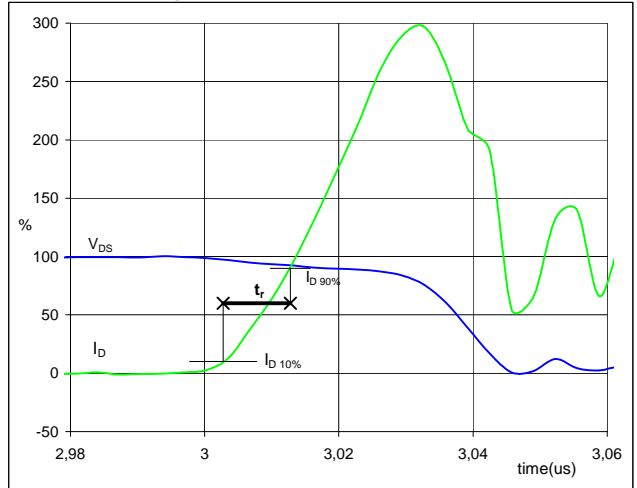
$V_{GS}(0\%) =$	0	V
$V_{GS}(100\%) =$	10	V
$V_D(100\%) =$	400	V
$I_D(100\%) =$	15	A
$t_{don} =$	0,03	$\mu$ S
$t_{Eon} =$	0,07	$\mu$ S

**Figure 3** BOOST MOSFET

**Turn-off Switching Waveforms & definition of  $t_f$** 


$V_D(100\%) =$	400	V
$I_D(100\%) =$	15	A
$t_f =$	0,004	$\mu$ S

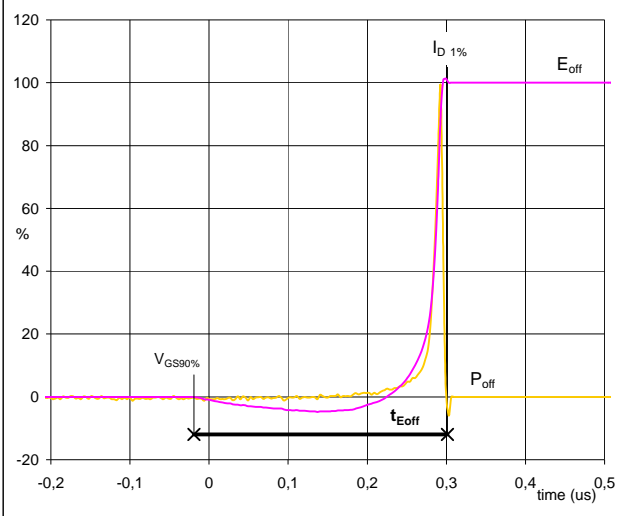
**Figure 4** BOOST MOSFET

**Turn-on Switching Waveforms & definition of  $t_r$** 


$V_D(100\%) =$	400	V
$I_D(100\%) =$	15	A
$t_r =$	0,01	$\mu$ S

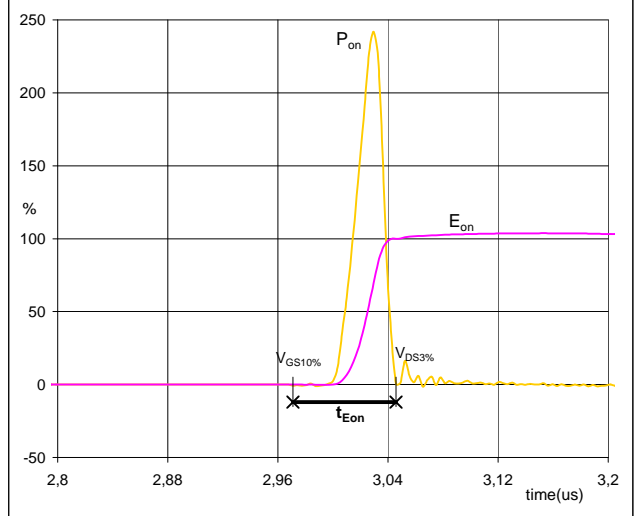
## Switching Definitions Boost MOSFET

**Figure 5** BOOST MOSFET

**Turn-off Switching Waveforms & definition of  $t_{Eoff}$** 


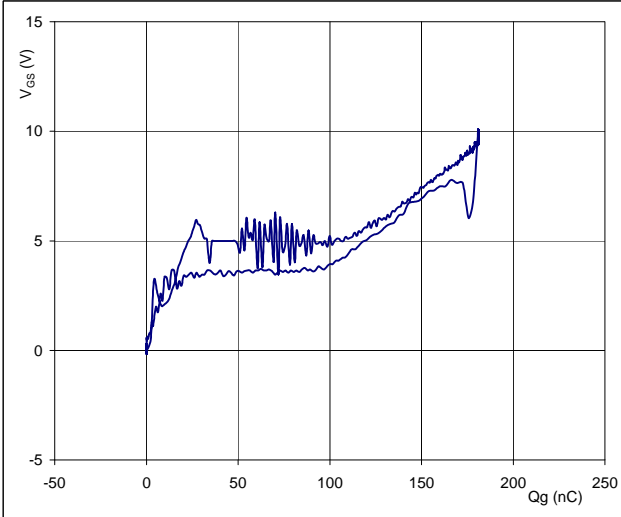
$P_{off} (100\%) =$	6,02	kW
$E_{off} (100\%) =$	0,08	mJ
$t_{Eoff} =$	0,32	$\mu$ s

**Figure 6** BOOST MOSFET

**Turn-on Switching Waveforms & definition of  $t_{Eon}$** 


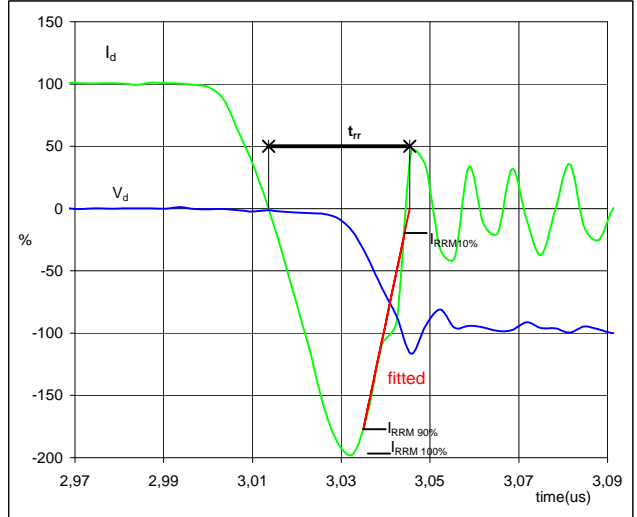
$P_{on} (100\%) =$	6,02	kW
$E_{on} (100\%) =$	0,34	mJ
$t_{Eon} =$	0,07	$\mu$ s

**Figure 7** BOOST MOSFET

**Gate voltage vs Gate charge (measured)**


$V_{GSoff} =$	0	V
$V_{GSon} =$	10	V
$V_D (100\%) =$	400	V
$I_D (100\%) =$	15	A
$Q_g =$	181	nC

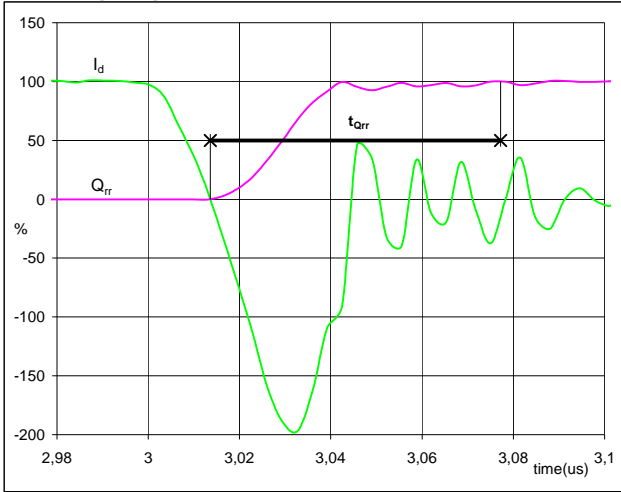
**Figure 8** BOOST FWD

**Turn-off Switching Waveforms & definition of  $t_{rr}$** 


$V_D (100\%) =$	400	V
$I_D (100\%) =$	15	A
$I_{RRM} (100\%) =$	-30	A
$t_{rr} =$	0,03	$\mu$ s

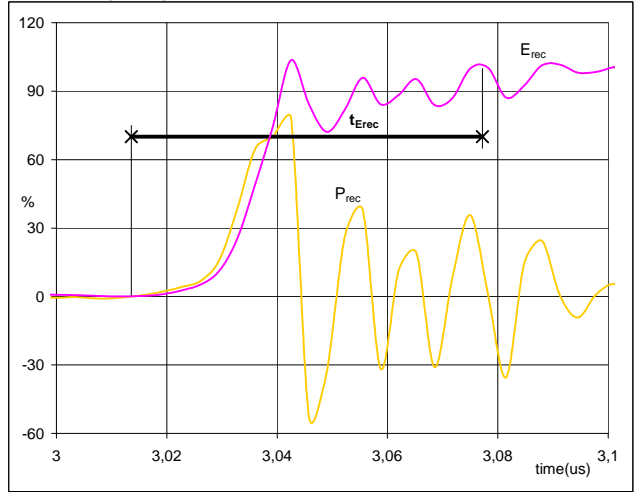
## Switching Definitions Boost MOSFET

**Figure 9** BOOST FWD

**Turn-on Switching Waveforms & definition of  $t_{Qrr}$**   
 ( $t_{Qrr}$  = integrating time for  $Q_{rr}$ )


$I_d$ (100%) =	15	A
$Q_{rr}$ (100%) =	0,56	$\mu\text{C}$
$t_{Qrr}$ =	0,06	$\mu\text{s}$

**Figure 10** BOOST FWD

**Turn-on Switching Waveforms & definition of  $t_{Erec}$**   
 ( $t_{Erec}$  = integrating time for  $E_{rec}$ )


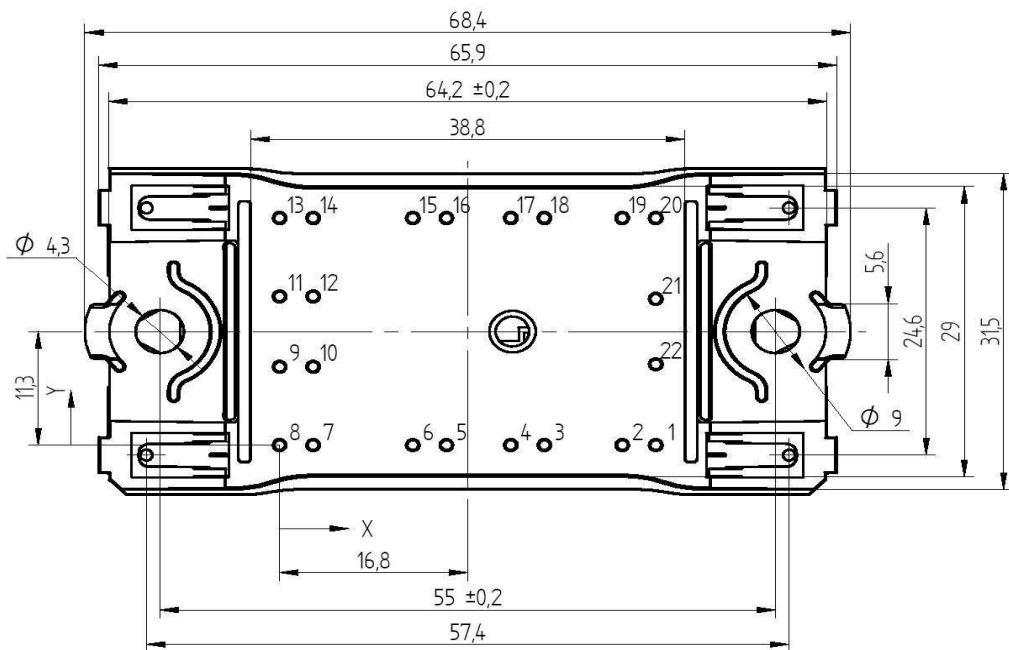
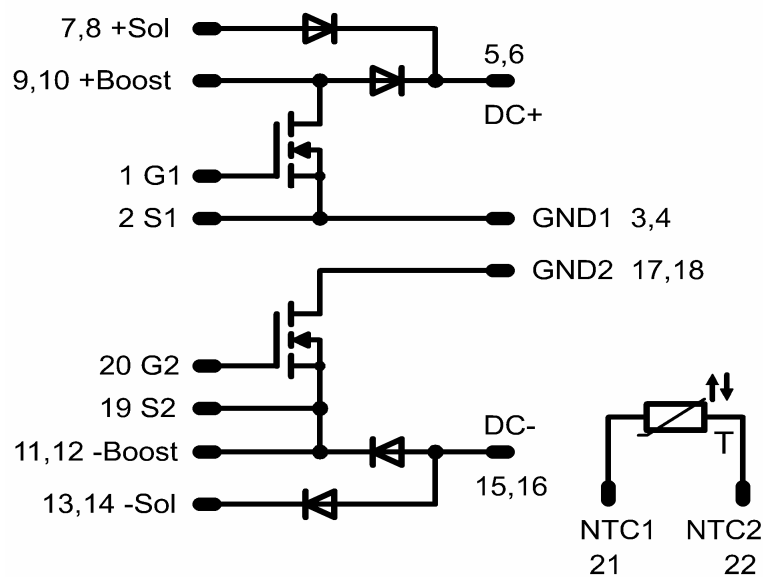
$P_{rec}$ (100%) =	6,02	kW
$E_{rec}$ (100%) =	0,08	mJ
$t_{Erec}$ =	0,06	$\mu\text{s}$

**Ordering Code and Marking - Outline - Pinout**
**Ordering Code & Marking**

Version	Ordering Code	in DataMatrix as	in packaging barcode as
Standard in flow0 12mm housing	10-FZ06NBA041FS01-P915L78	P915L78	P915L78

**Outline**

Pin table		
Pin	X	Y
1	33,6	0
2	30,6	0
3	23,65	0
4	20,65	0
5	14,9	0
6	11,9	0
7	3	0
8	0	0
9	0	7,8
10	3	7,8
11	0	14,8
12	3	14,8
13	0	22,6
14	3	22,6
15	11,9	22,6
16	14,9	22,6
17	20,65	22,6
18	23,65	22,6
19	30,6	22,6
20	33,6	22,6
21	33,6	14,55
22	33,6	8,05


**Pinout**




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